National Semiconductor

54F/74F563 Octal D-Type Latch with TRI-STATE® Outputs

General Description

The 'F563 is a high-speed octal latch with buffered common Latch Enable (LE) and buffered common Output Enable (OE) inputs.

Features

- Inputs and outputs on opposite sides of package allowing easy interface with microprocessors
- Useful as input or output port for microprocessors
- Functionally identical to 'F573

This device is functionally identical to the 'F573, but has inverted outputs.



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Absolute Maximum Ratings (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

-65°C to +150°C
-55°C to +125°C
-55°C to +175°C
-55°C to +150°C
-0.5V to $+7.0V$
-0.5V to $+7.0V$
-30 mA to $+5.0$ mA
-0.5V to V _{CC}
-0.5V to $+5.5V$

in LOW State (Max) twice the rated I_{OL} (mA) Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

DC Electrical Characteristics

Recommended Operating Conditions

Free Air Ambient Temperature Military Commercial

 -55°C to $+125^\circ\text{C}$ $0^{\circ}C$ to $\,+\,70^{\circ}C$

Supply Voltage Commercial

Military

+4.5V to +5.5V+4.5V to +5.5V

DC Electrical Characteristics											
Symbol	Parameter		54F/74F			Units	Voo	Conditions			
oymbol			Min	Тур	Max						
VIH	Input HIGH Voltage		2.0		30 2	v		Recognized as a HIGH Signal			
VIL	Input LOW Voltage				0.8	V		Recognized as a LOW Signal			
V _{CD}	Input Clamp Diode Voltage				-1.2	V	Min	$I_{IN} = -18 \text{ mA}$			
V _{OH}	Output HIGH Voltage	54F 10% V _{CC} 54F 10% V _{CC} 74F 10% V _{CC} 74F 10% V _{CC} 74F 5% V _{CC} 74F 5% V _{CC}	2.5 2.4 2.5 2.4 2.7 2.7	Ň		v	Min	$\begin{split} I_{OH} &= -1 \text{ mA} \\ I_{OH} &= -3 \text{ mA} \\ I_{OH} &= -1 \text{ mA} \\ I_{OH} &= -3 \text{ mA} \\ I_{OH} &= -1 \text{ mA} \\ I_{OH} &= -3 \text{ mA} \end{split}$			
V _{OL}	Output LOW Voltage	54F 10% V _{CC} 74F 10% V _{CC}			0.5 0.5	v	Min	$I_{OL} = 20 \text{ mA}$ $I_{OL} = 24 \text{ mA}$			
I _Н	Input HIGH Current	54F 74F			20.0 5.0	μΑ	Max	$V_{IN} = 2.7V$			
I _{BVI}	Input HIGH Current Breakdown Test	54F 74F			100 7.0	μΑ	Max	$V_{IN} = 7.0V$			
ICEX	Output HIGH Leakage Current	54F 74F			250 50	μΑ	Max	$V_{OUT} = V_{CC}$			
V _{ID}	Input Leakage Test	74F	4.75			v	0.0	$I_{ID} = 1.9 \ \mu A$ All Other Pins Grounded			
I _{OD}	Output Leakage Circuit Current	74F			3.75	μΑ	0.0	V _{IOD} = 150 mV All Other Pins Grounded			
IIL	Input LOW Current				-0.6	mA	Max	$V_{IN} = 0.5V$			
I _{OZH}	Output Leakage Curre	ent			50	μΑ	Max	$V_{OUT} = 2.7V$			
I _{OZL}	Output Leakage Curre	ent			-50	μΑ	Max	$V_{OUT} = 0.5V$			
I _{OS}	Output Short-Circuit C	Current	-60		-150	mA	Max	$V_{OUT} = 0V$			
I _{ZZ}	Bus Drainage Test				500	μΑ	0.0V	V _{OUT} = 5.25V			
ICCL	Power Supply Current	t		40	61	mA	Max	$V_{O} = LOW$			
Iccz	Power Supply Curren	t		40	61	mA	Max	V _O = HIGH Z			

	-		74F		5	4F	7	4F		
Symbol	Parameter	T _A = +25°C V _{CC} = +5.0V C _L = 50 pF			T _A , V _C C _L =	_C = Mil 50 pF	$\begin{array}{l} {\sf T_A,V_{CC}=Com}\\ {\sf C_L=50pF} \end{array}$		Units	
		Min	Тур	Мах	Min	Max	Min	Max	1	
PLH PHL	Propagation Delay D_n to \overline{O}_n	3.5 2.5		8.5 6.5	3.0 2.0	10.5 7.5	3.0 2.0	9.5 7.0	ns	
PLH PHL	Propagation Delay LE to \overline{O}_n	4.5 3.0		9.5 7.0	4.0 2.5	11.0 7.5	4.0 2.5	10.5 7.0	ns	
PZH PZL	Output Enable Time	2.0 3.0		7.5 8.5	2.0 2.5	9.5 10.0	2.0 1.5	9.0 9.5	ns	
PHZ PLZ	Output Disable Time	1.5 1.5		5.5 5.5	1.5 1.5	7.0 5.5	1.5 1.5	6.5 5.5		
AC Or	berating Require	ements	6		1				1	
•			74F		54F		74F		n Units	
Symbol	Parameter		$\begin{array}{l} \textbf{T_A}=\ +\ \textbf{25^{\circ}C}\\ \textbf{V_{CC}}=\ +\ \textbf{5.0V} \end{array}$		$T_A, V_{CC} = Mil$		$T_A, V_{CC} = Cc$			
. (1.1)			Min Ma	x	Min	Max	Min	Max		
_s (H) _s (L)	D _n to LE	JVV	2.0 2.0		2.0	23	2.0		ns	
_h (H) _h (L)	Hold Time, HIGH or LO D _n to LE	w	3.0 3.0		3.0 3.0	-0	3.0 3.0		ns	
w(H)	LE Pulse Width, HIGH		4.0		4.0	0	4.0		ns	
defined a	nperature Range Family	partora	<u>74F</u> <u>563</u>			cial Variation $X = Devices$	shipped in	13" reels	inge are	
7 5 Dev Pao	4F = Military vice Type				QE Ten	3 = Military (environr process	grade device nental and b ing shipped nge	e with ourn-in in tubes		







